

(a) depositing a first film of p-type copper indium diselenide film on a

metal back contact

- (b) depositing on the upper surface of the copper indium diselenide film a group IIb halide [(a,b) and VII elemental salt]:
- (c) [converting] <u>doping</u> the p-type [the] upper copper indium diselenide film surface n-type by thermal diffusion of the [salt] <u>group IIb halide</u> into the copper indium diselenide film <u>surface and cleaning the n-type</u> surface:
- (d) depositing a second thin film layer of high resistivity zinc oxide; and
- (e) depositing a third film of n-type transparent zinc oxide on the second thin film high resistivity zinc oxide layer.

Please amend claim 2, as follows:

(once amended) A process according to claim [I in which] 1 wherein
the group IIb halide [(a,b) and VII elemental salt] is zinc chloride.

Please rewrite claims 6 and 7, as follows:

Claim 6, line 20, delete "elemental salt" and substitute therefor --group IIb

halide--

Claim 7, line 22, delete "elemental salt" and substitute therefor --group IIb

halide--

Please amend claims 8, 10, and 11, as follows: